Searcl	h Notes	S
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/648,618	LEHMBERG ET AL.
Examiner	Art Unit
Anthony Weier	1761

	SEARCHED		
Class	Subclass	Date	Examiner
updated	previous search	3/12/2007	AW
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INTERFERENCE SEARCHED			TERFERENCE SEARCHED		
Class	Subclass	Date	Examiner		
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